

MOS Field Effect Transistor 2SK3480

■ Features

- Super low on-state resistance:
 $R_{DS(on)1} = 31 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 25 \text{ A)}$
 $R_{DS(on)2} = 36 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 25 \text{ A)}$
- Low C_{iss} : $C_{iss} = 3600 \text{ pF TYP.}$
- Built-in gate protection diode



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit	
Drain to source voltage	V_{DS}	100	V	
Gate to source voltage	V_{GS}	± 20	V	
Drain current	I_D	± 50	A	
	I_{dp}^*	± 100	A	
Power dissipation	P_D	$T_c=25^\circ\text{C}$	84	W
		$T_a=25^\circ\text{C}$	1.5	
Channel temperature	T_{ch}	150	$^\circ\text{C}$	
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$	

* $PW \leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit
Drain cut-off current	I_{DSS}	$V_{DS}=100\text{V}, V_{GS}=0$			10	μA
Gate leakage current	I_{GSS}	$V_{GS}=\pm 20\text{V}, V_{DS}=0$			± 10	μA
Gate cutoff voltage	$V_{GS(off)}$	$V_{DS}=10\text{V}, I_D=1\text{mA}$	1.5	2.0	2.5	V
Forward transfer admittance	$ Y_{fs} $	$V_{DS}=10\text{V}, I_D=25\text{A}$	17	34		S
Drain to source on-state resistance	$R_{DS(on)1}$	$V_{GS}=10\text{V}, I_D=25\text{A}$		25	31	$\text{m}\Omega$
	$R_{DS(on)2}$	$V_{GS}=4.5\text{V}, I_D=25\text{A}$		27	36	$\text{m}\Omega$
Input capacitance	C_{iss}	$V_{DS}=10\text{V}, V_{GS}=0, f=1\text{MHz}$		3600		pF
Output capacitance	C_{oss}			360		pF
Reverse transfer capacitance	C_{rss}			190		pF
Turn-on delay time	t_{on}	$I_D=25\text{A}, V_{GS(on)}=10\text{V}, R_G=0\Omega, V_{DD}=50\text{V}$		15		ns
Rise time	t_r			11		ns
Turn-off delay time	t_{off}			68		ns
Fall time	t_f			6.0		ns
Total Gate Charge	Q_G				74	
Gate to Source Charge	Q_{GS}	$I_D=50\text{A}, V_{DD}=80\text{V}, V_{GS}=10\text{V}$		10		nC
Gate to Drain Charge	Q_{GD}			20		nC